

Notice of References Cited	Application/Control No. 10/711,470	Applicant(s)/Patent Under Reexamination SHEI ET AL.	
	Examiner Thien T. Mai	Art Unit 2876	Page 1 of 1

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	B	US-2002/0104449	08-2002	Lee, Hung Hsiang	101/129
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NON-PATENT DOCUMENTS

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